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Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	55.2	0.97 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	54.6 ± 6%	0.99mho/m ± 6 %
Body TSL temperature during test	(21.9 ± 0.2) °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	2.41 mW / g
SAR normalized	normalized to 1W	9.64 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	9.28 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	1.58 mW / g
SAR normalized	normalized to 1W	6.32 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	6.19 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	53.7 Ω -3.7 j Ω
Return Loss	- 25.9dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	49.4 Ω - 5.1 j Ω
Return Loss	-25.6dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.387 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	April 22, 2004

DASY5 Validation Report for Head TSL

Certificate No: D835V2-4d020_Jul09

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Date/Time: 2009-7-15 14:54:13

Test Laboratory: TMC, Beijing, China

DUT: Dipole 835 MHz; Type: D835V2; Serial: SN: 4d020

Communication System: CW Frequency: 835 MHz Duty Cycle: 1:1

Medium: Head 835MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.91 \text{ mho/m}$; $\epsilon_r = 41.2$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(6.34, 6.34, 6.34); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=15mm/Zoom Scan (7x7x7)/Cube 0:

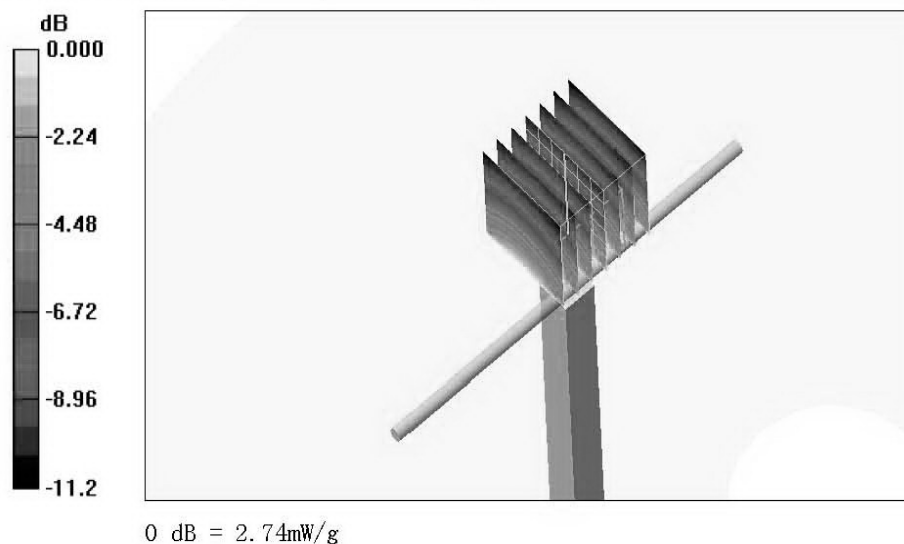
Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$

Reference Value = 55.2 V/m; Power Drift = -0.019 dB

Peak SAR (extrapolated) = 3.16 W/kg

SAR(1 g) = 2.4 mW/g; SAR(10 g) = 1.55 mW/g

Maximum value of SAR (measured) = 2.74 mW/g

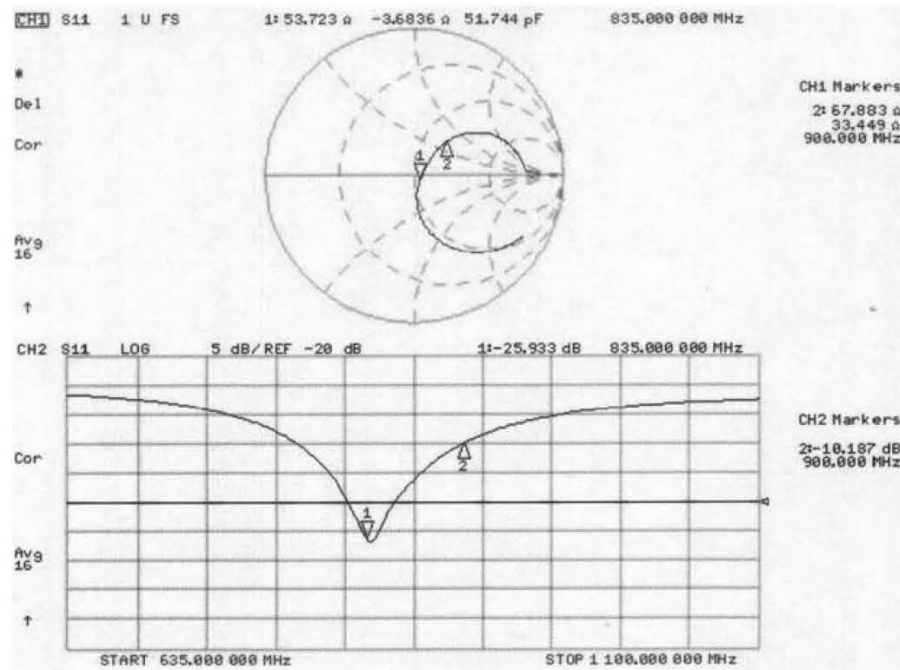


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Impedance Measurement Plot for Head TSL



DASY5 Validation Report for Body TSL

Date/Time: 2009-7-15 11:27:23

Test Laboratory: TMC, Beijing, China

DUT: Dipole 835 MHz; Type: D835V2; Serial: SN: 4d020

Communication System: CW Frequency: 835 MHz Duty Cycle: 1:1

Medium: Body 835MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.99 \text{ mho/m}$; $\epsilon_r = 54.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(6.02, 6.02, 6.02); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=15mm/Zoom Scan (7x7x7)/Cube 0:

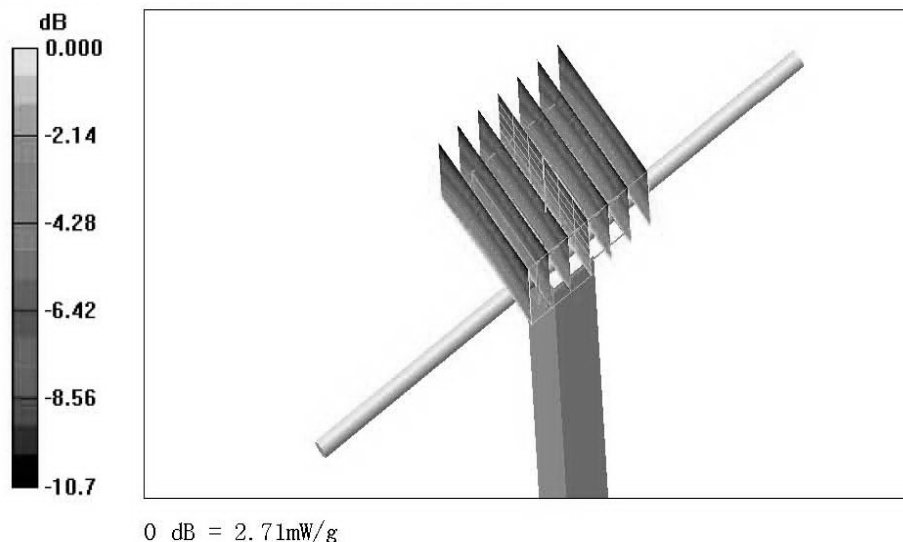
Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$

Reference Value = 54.1 V/m ; Power Drift = -0.004 dB

Peak SAR (extrapolated) = 3.81 W/kg

SAR(1 g) = 2.41 mW/g; SAR(10 g) = 1.58 mW/g

Maximum value of SAR (measured) = 2.71 mW/g

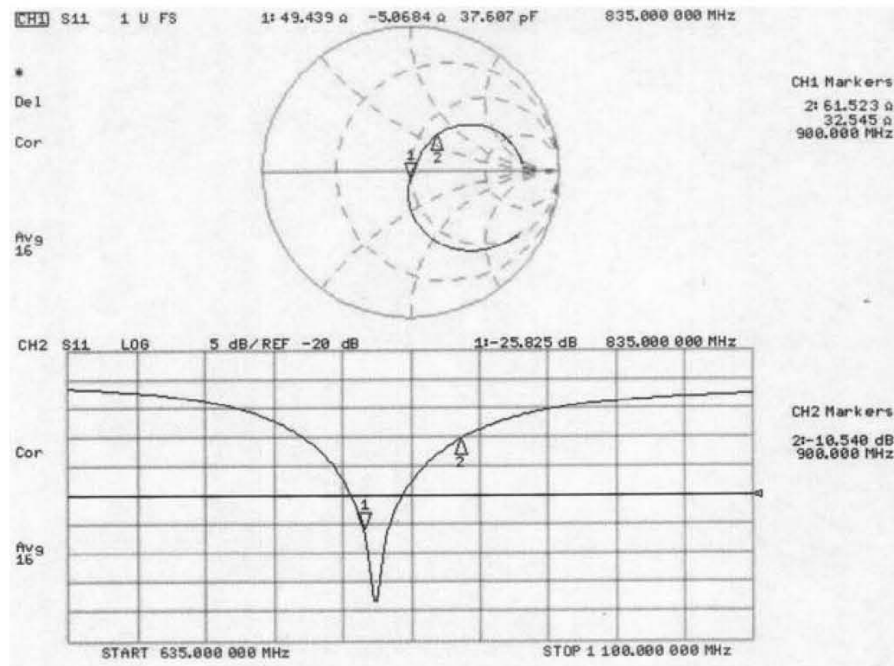


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Impedance Measurement Plot for Body TSL



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ANNEX F: DAE4 Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client **Auden**

Certificate No: DAE4-452_Nov08

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BJ - SN: 452**

Calibration procedure(s) **QA CAL-06.v12
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **November 18, 2008**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	30-Sep-08 (No: 7673)	Sep-09
Keithley Multimeter Type 2001	SN: 0810278	30-Sep-08 (No: 7670)	Sep-09
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	06-Jun-08 (in house check)	In house check: Jun-09

Calibrated by:	Name Dominique Steffen	Function Technician	Signature
Approved by:	Fin Bornholt	R&D Director	

Issued: November 18, 2008

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: DAE4-452_Nov08

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**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.585 $\pm$ 0.1% (k=2)	404.416 $\pm$ 0.1% (k=2)	404.565 $\pm$ 0.1% (k=2)
Low Range	3.97854 $\pm$ 0.7% (k=2)	3.95135 $\pm$ 0.7% (k=2)	3.98063 $\pm$ 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	148 ° $\pm$ 1 °
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Appendix

1. DC Voltage Linearity

High Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	200000	200000	0.00
Channel X + Input	20000	20006.89	0.03
Channel X - Input	20000	-20003.71	0.02
Channel Y + Input	200000	200000.5	0.00
Channel Y + Input	20000	20008.05	0.04
Channel Y - Input	20000	-20006.61	0.03
Channel Z + Input	200000	199999.6	0.00
Channel Z + Input	20000	20006.84	0.03
Channel Z - Input	20000	-20004.66	0.02

Low Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	200.19	0.09
Channel X - Input	200	-199.99	0.00
Channel Y + Input	2000	2000	0.00
Channel Y + Input	200	199.38	-0.31
Channel Y - Input	200	-200.73	0.36
Channel Z + Input	2000	2000.1	0.00
Channel Z + Input	200	199.25	-0.38
Channel Z - Input	200	-201.52	0.76

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	2.99	1.90
	- 200	-1.54	-1.85
Channel Y	200	-8.82	-8.73
	- 200	6.90	6.96
Channel Z	200	9.94	10.21
	- 200	-13.53	-13.21

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.31	-0.98
Channel Y	200	1.52	-	2.97
Channel Z	200	-1.16	0.18	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16123	16646
Channel Y	15886	16452
Channel Z	16175	16346

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.53	-0.80	1.64	0.33
Channel Y	-1.51	-2.67	-0.89	0.35
Channel Z	-1.99	-3.07	-1.43	0.29

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.1999	198.3
Channel Y	0.1999	200.1
Channel Z	0.1999	199.3

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9